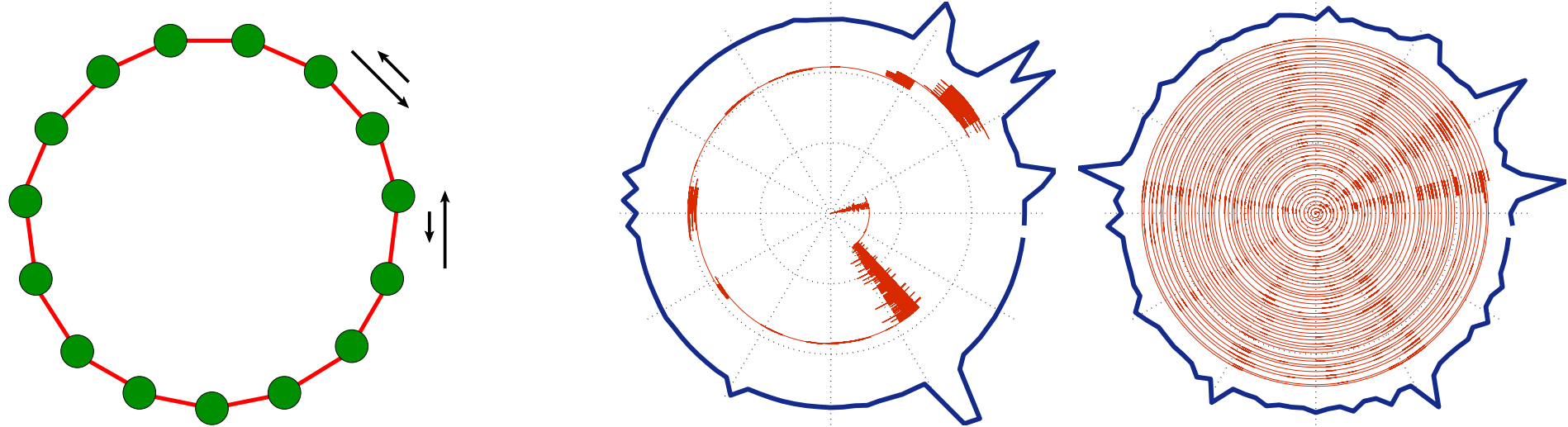


Percolation, sliding, localization and relaxation in topologically closed circuits

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[1] Daniel Hurowitz, DC [**Scientific Reports 2016**]

[2] Daniel Hurowitz, DC [**PRE 2016**]

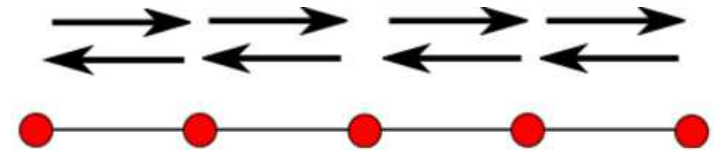
[3] Isaac Weinberg, Yaron de Leeuw, Tsampikos Kottos, DC [**PRE 2016**]

Types of random walk

Simple random walk, aka Brownian motion [Einstein]

Strictly periodic lattice ($a = 1$). All rates are equal (w)

$$D = w \quad (\text{near-neighbor hopping})$$



Random walk on a disordered lattice [1]

Random lattice. Symmetric transition rates w_n

$$P(w) \propto w^{\alpha-1} \quad (\text{for small } w)$$

$$D = \left\langle \frac{1}{w} \right\rangle^{-1} = \text{conductivity}$$

$\alpha \sim$ sparsity parameter
(resistor network calculation)

Non-percolating for $\alpha < 1$

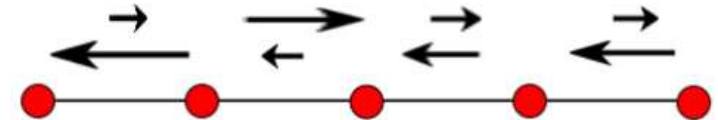
Percolation-like transition

Random walk in random environment [2]

Rates allowed to be asymmetric: $\overleftarrow{w}_n \neq \overrightarrow{w}_n$

Sub-diffusion for low bias [Sinai, Derrida,...]

Sliding transition



[1] Alexander, Bernasconi, Schneider, Orbach, Rev. Mod. Phys. (1981).

[2] Bouchaud, Comtet, Georges, Doussal, Annals Phys. (1990).

Definition of the model

Conservative rate equation

$$\frac{d\mathbf{p}}{dt} = \mathbf{W}\mathbf{p}$$

Rates allowed to be asymmetric $\vec{w}_n / \overleftarrow{w}_n = e^{\mathcal{E}_n}$

Affinity: $S_{\circlearrowleft} = \sum \mathcal{E}_n = Ns$

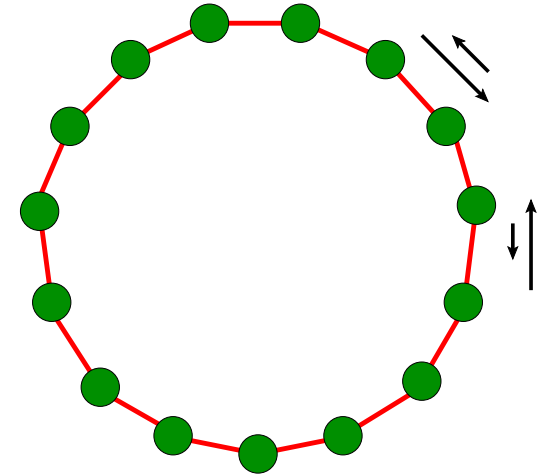
Stochastic field: $\mathcal{E}_n = s + \varsigma_n$ where $\varsigma_n \in [-\sigma, \sigma]$

Transition rates across n^{th} bond are $w_n e^{\pm \mathcal{E}_n / 2}$

Resistor network disorder: $P(w) \propto w^{\alpha-1}$

How do spectral properties of \mathbf{W} depend on (α, σ, s) ?

$\alpha \sim$ sparsity, $\sigma \sim$ field disorder, $s \sim$ affinity



$$\mathbf{W} = \begin{bmatrix} -\gamma_1 & w_{1,2} & 0 & \dots \\ w_{2,1} & -\gamma_2 & w_{2,3} & \dots \\ 0 & w_{3,2} & -\gamma_3 & \dots \\ \dots & \dots & \dots & \dots \end{bmatrix}$$

Sum of elements in each column is zero

Related models

Vortex depinning in type II superconductors ($s =$ applied transverse magnetic field)

- Hatano, Nelson, PRL (1996), PRB (1997).
- Shnerb, Nelson, PRL (1998).
- **Follow ups:** Brouwer, Silvestrov, Beenakker, PRB (1997). Goldsheid, Khoruzhenko, PRL (1998). Feinberg, Zee, PRE (1999). Molinari, Linear Algebra and its Applications (2008).

Pulling pinned polymers, DNA denaturation ($s =$ pulling force)

- Lubensky, Nelson, PRL (2000), PRE (2002).

Population biology ($s =$ convective flow of bacteria relative to the nutrients)

- Nelson, Shnerb, PRE (1998).
- Dahmen, Nelson, Shnerb, Springer (1999).

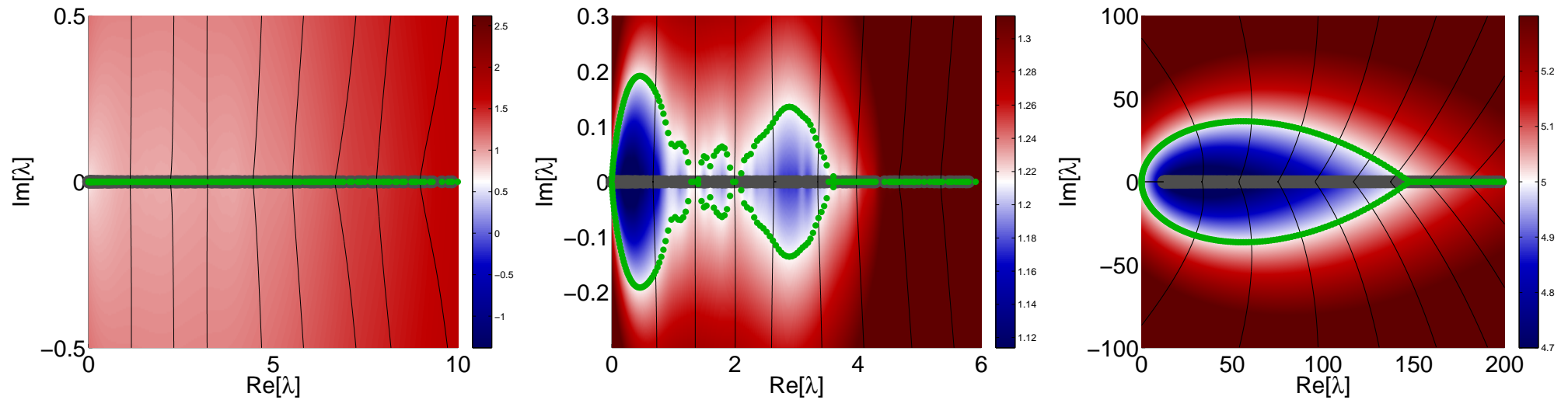
Molecular motors ($s =$ affinity of chemical cycle)

- Fisher, Kolomeisky, PNAS (1999).
- Rief et al, PNAS (2000).
- Kafri, Lubensky, Nelson, Biophysical Journal (2004), PRE (2005).

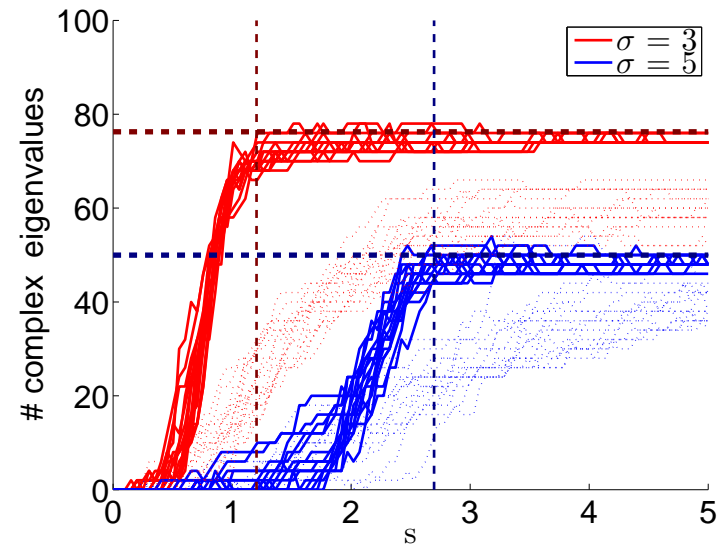
Non of the above concern relaxation modes of a conservative systems!

Implications of the percolation and sliding transitions on relaxation modes of the ring?

The spectrum of W



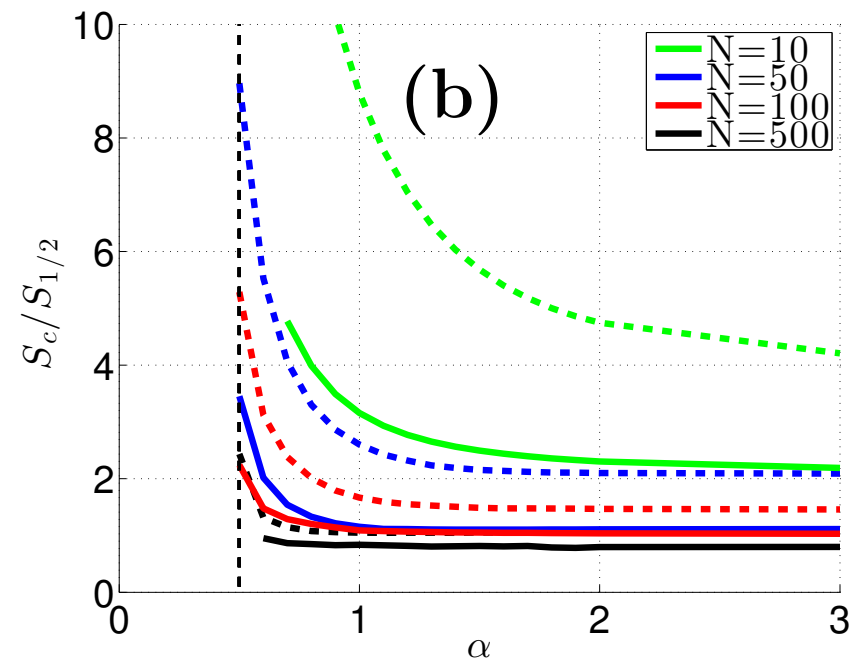
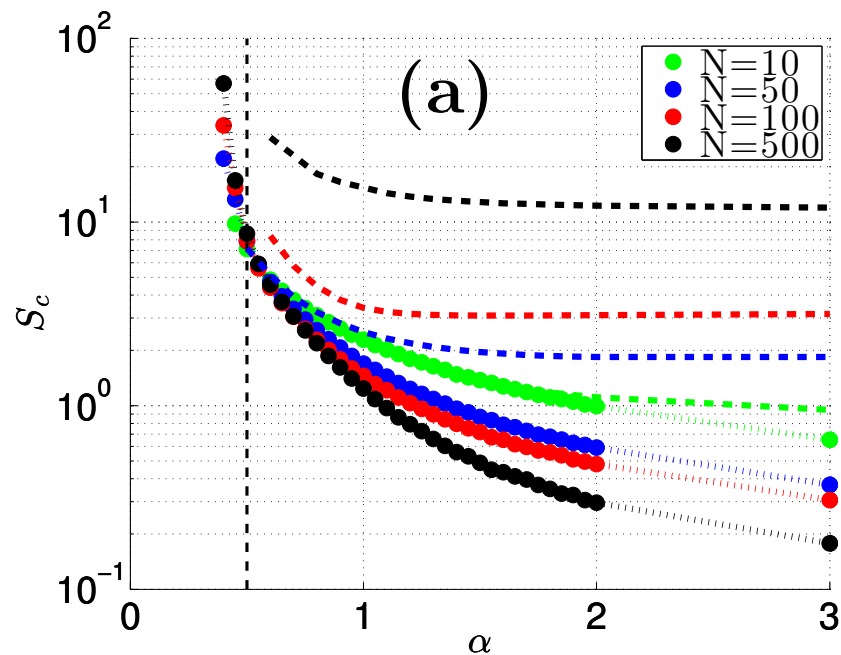
- Due to conservativity $\lambda_0 = 0$
- The other eigenvalues are $\{-\lambda_k\}$
- Complex bubble for $s > s_c$
- Complexity saturation for $s \gg s_\infty$
- Implication of the percolation transition?
- Implication of the sliding transition?



The complexity threshold (aka delocalization transition)

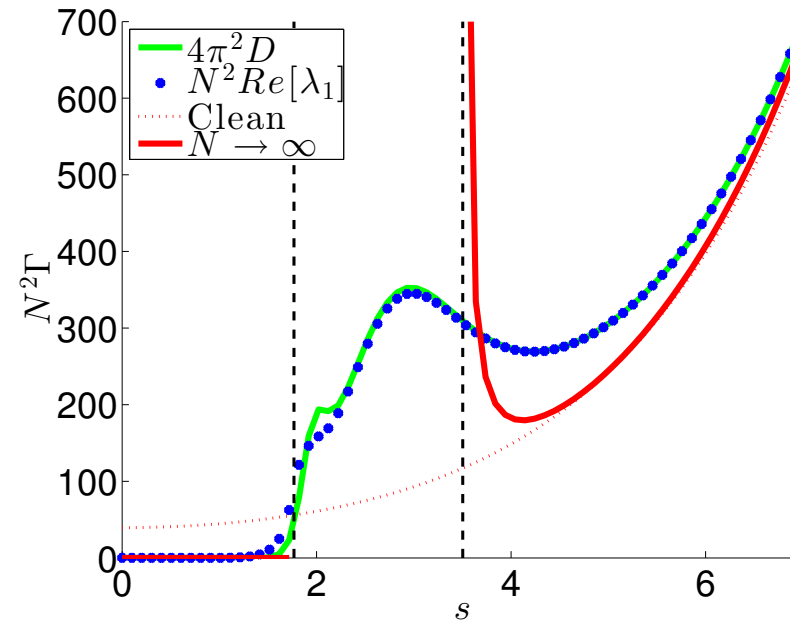
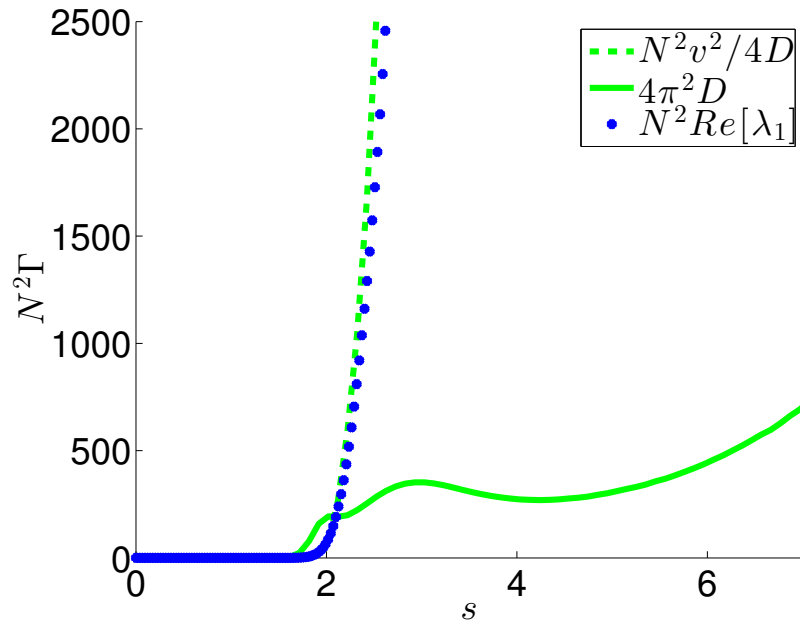
Naive expectation is $S_c = N s_1$ for $\alpha > 1$ and $S_c = \infty$ otherwise.

Type of disorder	Parameters	S_c for large N	Remarks
Resistor-network	$\alpha < \frac{1}{2}$ $\sigma = 0$	$S_c = \infty$	non-percolating (“disconnected ring”)
Resistor-network	$\frac{1}{2} < \alpha \ll 1$ $\sigma = 0$	$S_c \sim \mathcal{O}(1)$	residual percolation (“weak link”)
Resistor-network	$\alpha > 1$ $\sigma = 0$	$S_c \propto 1/\sqrt{N}$	percolating (conductivity $w_\infty > 0$)
Stochastic field	$\alpha > \frac{1}{2}$ $\sigma > 0$	$S_c \approx N s_{1/2}$	lower than sliding threshold at $N s_1$



The relaxation rate

Considering a ring of length $L = Na$ we define $\Gamma \equiv \text{Re}[\lambda_1]$



$$\Gamma[\text{box}] = \left[\left(\frac{\pi}{L} \right)^2 + \left(\frac{v}{2D} \right)^2 \right] D$$

$$\Gamma[\text{ring}] = \left(\frac{2\pi}{L} \right)^2 D$$

Explicit results for D are known
in the $N \rightarrow \infty$ limit.

From the analysis of the spectrum we deduce:

$$\Gamma[\text{ring}] \propto \begin{cases} L^{-\frac{1}{\mu}} & \text{for } s_{1/2} < s < s_1 \\ L^{-\left(3-\frac{2}{\mu}\right)} & \text{for } s_1 < s < s_2 \\ L^{-2} & \text{for } s > s_2 \end{cases}$$

The characteristic equation

We are looking for the eigenvalues $\{-\lambda_k\}$ of the matrix \mathbf{W} .

The characteristic polynomial is:

$$\det(z + \mathbf{W}) = \det(z + \tilde{\mathbf{W}}) = \det(z + \mathbf{H}) - 2 \left[\cosh \left(\frac{S_\odot}{2} \right) - 1 \right] \prod_{n=1}^N (-w_n)$$

$$\mathbf{W} = \text{diagonal} \left\{ -\gamma_n(\mathbf{s}) \right\} + \text{offdiagonal} \left\{ w_n e^{\pm \frac{\mathcal{E}_n}{2}} \right\} \quad \mathcal{E}_n = \mathbf{s} + \varsigma_n$$

$$\tilde{\mathbf{W}} = \text{diagonal} \left\{ -\gamma_n(\mathbf{s}) \right\} + \text{offdiagonal} \left\{ w_n e^{\pm \frac{S_\odot}{2N}} \right\} \quad S_\odot = N \mathbf{s}$$

$$\mathbf{H} = \text{diagonal} \left\{ -\gamma_n(\mathbf{s}) \right\} + \text{offdiagonal} \left\{ w_n \right\} \rightsquigarrow \text{diagonal} \left\{ -\epsilon_k(\mathbf{s}) \right\}$$

The characteristic equation:

$$\prod_k (z - \epsilon_k(\mathbf{s})) = 2 \left[\cosh \left(\frac{N\mathbf{s}}{2} \right) - 1 \right] (-\bar{w})^N$$

The electrostatic version:

$$\Psi(z) = \Psi(0)$$

RHS is $\Psi(0)$ because $\lambda_0=0$ is in the spectrum.

$$\Psi(z) \equiv \sum_k \ln(z - \epsilon_k(\mathbf{s})) \equiv V(x, y) + iA(x, y)$$

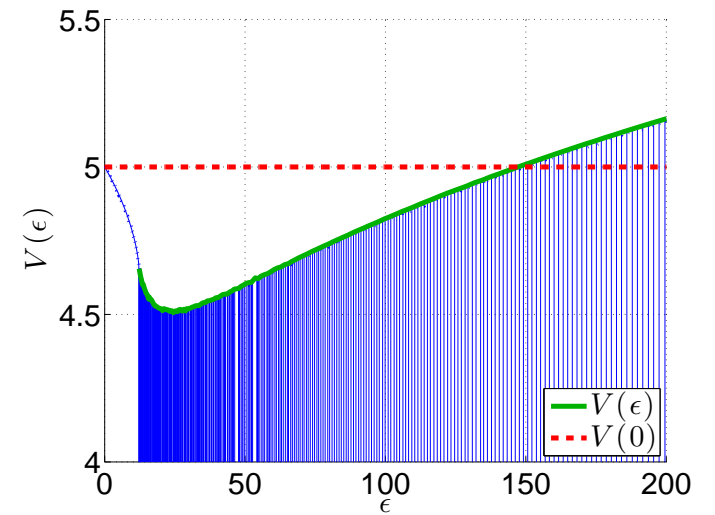
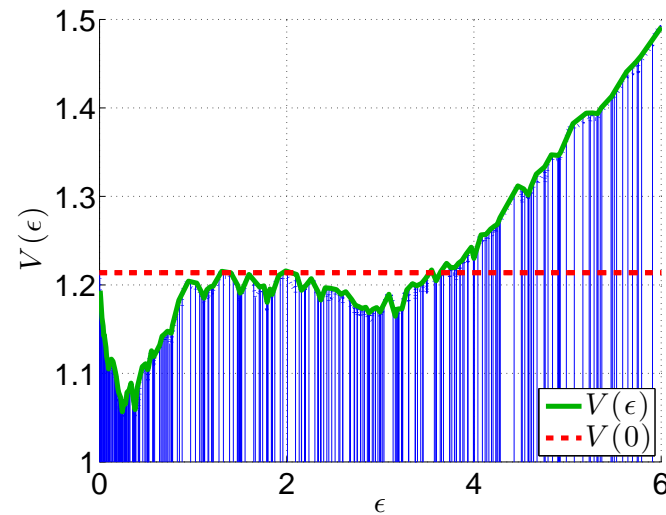
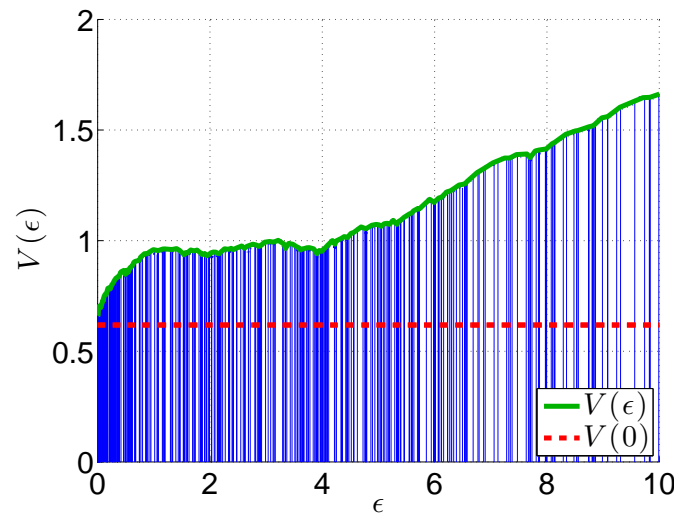
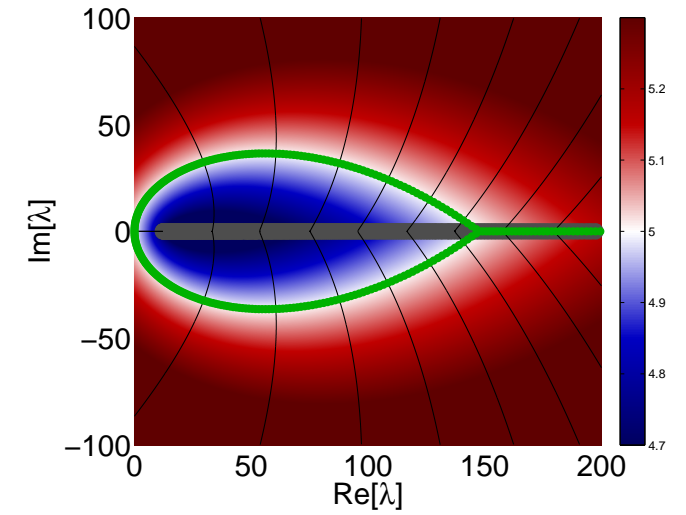
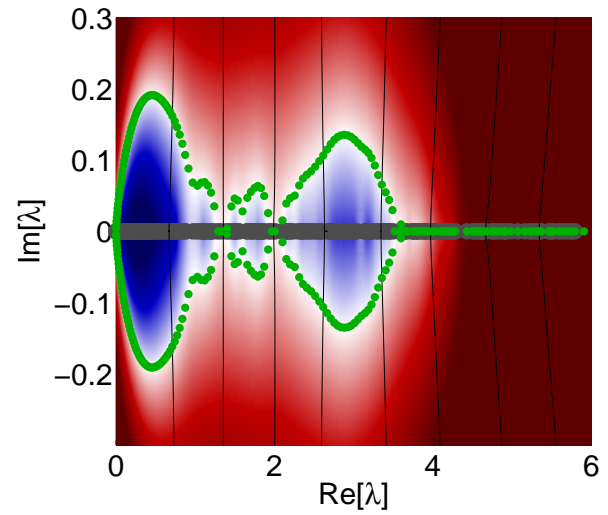
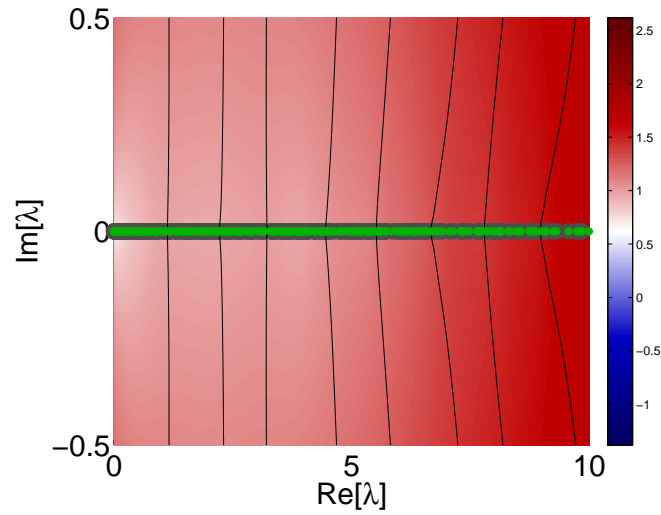
The electrostatic picture

The complex potential:

$$\Psi(z) = \sum_k \ln(z - \epsilon_k) = V(x, y) + iA(x, y)$$

Characteristic equation:

$$V(x, y) = V(0) \quad A(x, y) = 2\pi * \text{integer}$$



$s < s_c$

$s_c < s < s_\infty$

$s > s_\infty$

The formation of a complex bubble

The λ spectrum is real if $V(\epsilon) > V(0)$.

The characteristic equation is $V(\epsilon) = V(0)$

leading to $\lambda_k \sim \epsilon_k$

$$V(\epsilon) = \int \ln(|\epsilon - \epsilon'|) \rho(\epsilon') d\epsilon' \sim \text{inverse localization length}$$

- For Anderson problem - $V(\epsilon)$ diverges at the band edge
- For Debye model - $V(\epsilon)$ goes to zero at the band edge
- **A conservative H is formally like Debye model**
- As the affinity is increased the conservativity of H is spoiled.

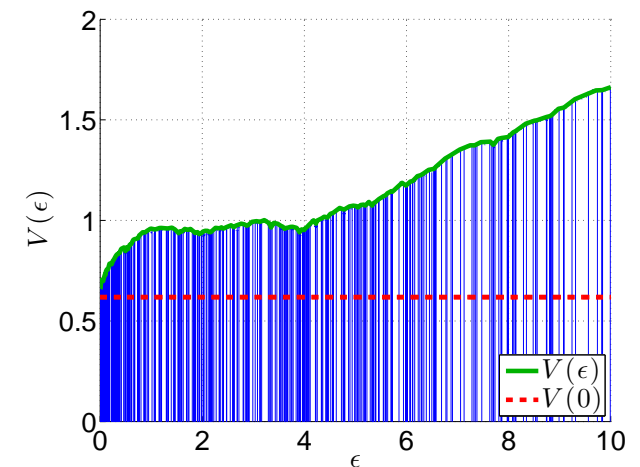
In non-conservative models [Hatano, Nelson, Shnerb]:

- The characteristic equation is $V(\epsilon) = f(s)$ with $f(s) \neq V(0)$
- A complex bubble appears in the middle of the spectrum, where $V(\epsilon)$ is small

Charge density:

$$\rho(\epsilon) \equiv \sum_k \delta(\epsilon - \epsilon_k(s))$$

Electrostatic potential:



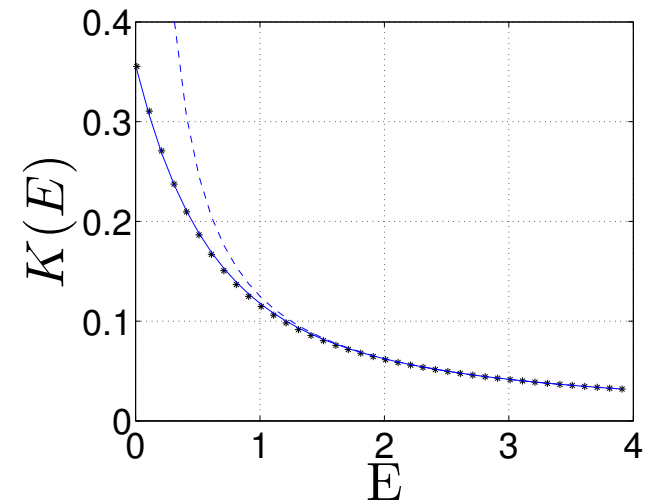
Digression - Debye vs Anderson localization

The inverse localization length based on Halperin [PhysRev 1965] and Thouless relation:

$$V(\epsilon) = \left(\frac{\text{Var}(v_n)}{2w_0^2} \right)^{1/3} \mathcal{K} \left[\left(2 \frac{[\text{Var}(v_n)]^2}{w_0} \right)^{-1/3} \epsilon \right]$$

Born approximation:

$$V(\epsilon) \approx \frac{1}{8} \left[\frac{\text{Var}(v_n)}{w_0^2} \right] \left(\frac{\epsilon}{w_0} \right)^{-1}$$



$$\mathcal{K}(E) \approx \left[1 - e^{-2.86E} \right] \frac{1}{8E}$$

We have established a duality that relates Debye localization to weak diagonal disorder:

$$V(\epsilon) = \left(\frac{1}{2} \left[w_\infty^2 \text{Var} \left(\frac{1}{w_n} \right) \right] \left(\frac{\epsilon}{w_\infty} \right)^2 \right)^{\frac{1}{3}} \mathcal{K} \left[\left(2 \left[w_\infty^2 \text{Var} \left(\frac{1}{w_n} \right) \right]^2 \left(\frac{\epsilon}{w_\infty} \right) \right)^{-\frac{1}{3}} \right]$$

Dual Born approximation:

$$V(\epsilon) \approx \frac{1}{8} \left[w_\infty^2 \text{Var} \left(\frac{1}{w_n} \right) \right] \left(\frac{\epsilon}{w_\infty} \right)$$

$w_\infty = \text{conductivity}$

The determination of s_c

In the absence of disorder we have a band. The band floor is

$$\epsilon_s = 2 [\cosh(s/2) - 1]$$

For **sparse disorder** there are out-of-band impurities.

For **full disorder** if $s < s_\infty$ we have by def $\epsilon_s = 0$. Accordingly

$$\rho(\epsilon) = \epsilon^{\mu-1} \quad (\text{for small } \epsilon) \quad [\mu \text{ depends on } s]$$

We define s_∞ as the value of s for which $\mu = \infty$

The threshold s_c is determined respectively from the conditions

$$V(\epsilon_s) < V(0) \quad \text{or} \quad V'(0) < 0$$

$$V(\epsilon) = \int \ln(|\epsilon - \epsilon'|) \rho(\epsilon') d\epsilon'$$

$$V'(\epsilon \rightarrow 0) \approx \frac{\epsilon^{\mu-1}}{\epsilon_c^\mu} \pi \mu \cot(\pi \mu)$$

The derivative changes sign from positive to negative at $\mu = 1/2$.

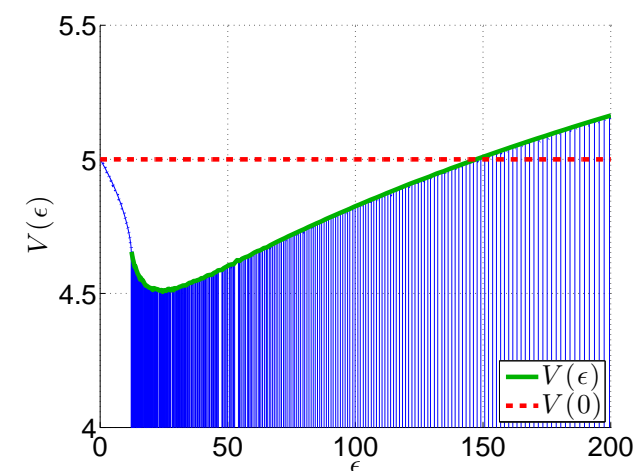
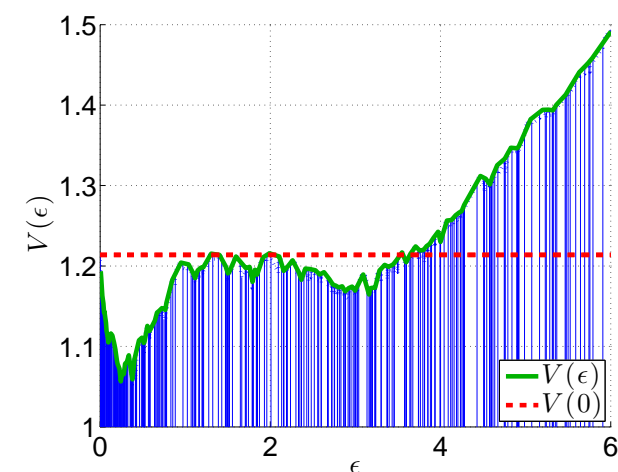
We define $s_{1/2}$ as the value of s for which $\mu = 1/2$

For full disorder we make the identification $s_c = s_{1/2}$.

Charge density:

$$\rho(\epsilon) \equiv \sum_k \delta(\epsilon - \epsilon_k(s))$$

Electrostatic potential:



Digression - the determination of μ

The thresholds s_μ are defined from

$$\langle e^{-\mu \mathcal{E}} \rangle \equiv e^{-(s-s_\mu)\mu}$$

For an infinite chain:

$$D = 0 \quad \text{for } s < s_{1/2},$$

$$v = 0 \quad \text{for } s < s_1.$$

For Gaussian disorder: $s_\mu = \frac{1}{2}\sigma^2\mu$

For Box disorder: $s_\mu = \frac{1}{\mu} \ln \left(\frac{\sinh(\sigma\mu)}{\sigma\mu} \right)$

In the latter case note that $s_\infty = \sigma$.

With a given s we associate μ such that $s = s_\mu$.

This μ is reflected in the time dependent spreading $x \sim t^\mu$

Correspondingly it is reflected in the density of eigenvalues:

$$\rho(\epsilon) \propto \epsilon^{\mu-1} \quad (\text{for small } \epsilon)$$

For $s > s_\infty$ a gap is opened.

Resistor network disorder

Identical bonds means $\alpha = \infty$.

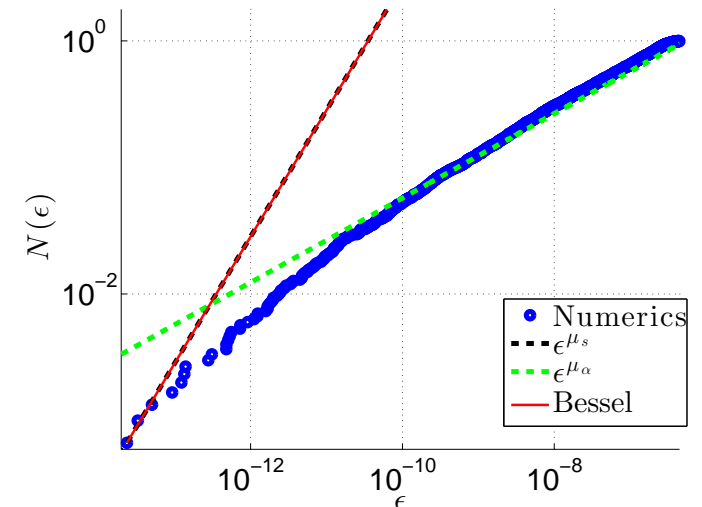
Otherwise we have $\mu(s) < \alpha < \infty$.

$$\mu = \frac{\alpha}{1+\alpha} \quad \text{for } \alpha < 1, s = \sigma = 0$$

$$\mu = \frac{1}{2} \quad \text{for } \alpha > 1, s = \sigma = 0$$

$$\mu = \alpha \quad \text{adding large } s$$

With field disorder ($\sigma > 0$):



Digression - ring with a weak link

Using transfer matrix methods we find the characteristic equation in the continuum limit

$$\cos(k) - \frac{1}{g} \frac{k^2 + \left(\frac{S_\odot}{2}\right)^2}{2k} \sin(k) = \cosh\left(\frac{S_\odot}{2}\right)$$

$$k^2 = (L^2/D)z - (S_\odot/2)^2$$

$$g = (D_1/a)/(D_0/L)$$

We have taken above the limit $a \rightarrow 0$, keeping (L, g, S_\odot) constant.

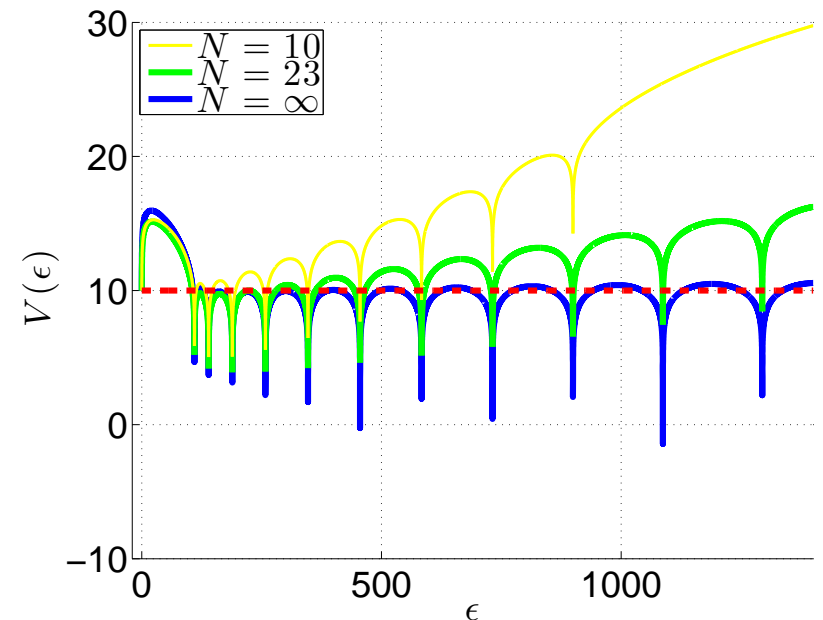
The threshold S_c is the solution of

$$\frac{S_\odot}{2g} = \cosh\left[\frac{S_\odot}{2}\right]$$

We can identify the electrostatic potential as

$$V(\epsilon) = \ln[2(\text{LHS} - 1)] = \sum_{k=1}^{\infty} \ln|\epsilon - \epsilon_k|$$

In order to reconstruct the potential from the ϵ_k we have to take into account the ϵ_0 that corresponds to an impurity-level associated with a mode which is located at the weak-link.



Plot of the electrostatic potential along the real axis ($z = \epsilon$)

Complexity saturation

The cutoff frequency ϵ_c of the complex bubble is determined by the characteristic equation

$$\sum_k \ln |\epsilon - \epsilon_k(\mathbf{s})| = \ln \left\{ 2 \left[\cosh \left(\frac{N\mathbf{s}}{2} \right) - 1 \right] \right\}$$

We can solve it easily for $s \gg s_\infty$

$$\epsilon_k(\mathbf{s}) \mapsto \gamma_n \approx w_n e^{\mathcal{E}_n/2}$$

$$\epsilon_n(\mathbf{s}) = w_n e^{(s+\varsigma_n)/2} \quad \varsigma_n \in [-\sigma, +\sigma]$$

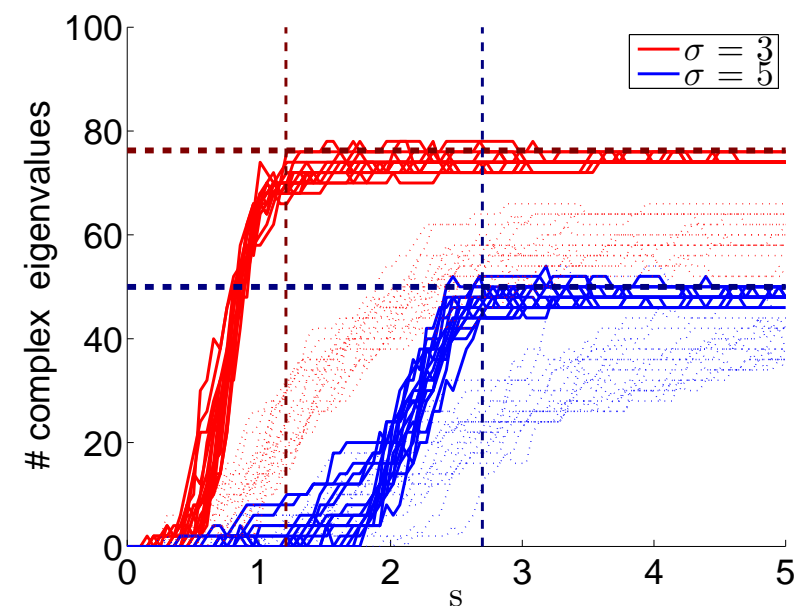
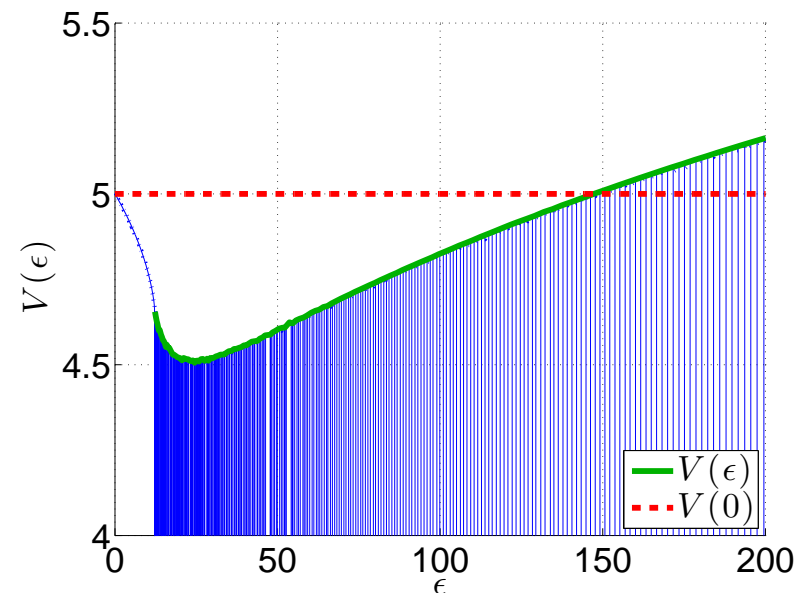
$$\epsilon_c(\mathbf{s}) \equiv \bar{w} e^{(s+\sigma_c)/2}$$

The characteristic equation takes the form

$$\frac{1}{N} \sum_n \ln \left| \bar{w} e^{(s+\sigma_c)/2} - w_n e^{(s+\varsigma_n)/2} \right| = \frac{s}{2}$$

We get an s independent equation for σ_c

$$\overline{\ln \left[\bar{w} e^{\sigma_c/2} - w e^{s/2} \right]} = 0$$



Summary

Relaxation properties of a closed circuit, whose dynamics is generated by a conservative rate-equation, are dramatically different from that of a biased non-hermitian Hamiltonian.

Type of disorder	Parameters	S_c for large N	Remarks
Resistor-network	$\alpha < \frac{1}{2}$ $\sigma = 0$	$S_c = \infty$	non-percolating (“disconnected ring”)
Resistor-network	$\frac{1}{2} < \alpha \ll 1$ $\sigma = 0$	$S_c \sim \mathcal{O}(1)$	residual percolation (“weak link”)
Resistor-network	$\alpha > 1$ $\sigma = 0$	$S_c \propto 1/\sqrt{N}$	percolating (conductivity $w_\infty > 0$)
Stochastic field	$\alpha > \frac{1}{2}$ $\sigma > 0$	$S_c \approx N s_{1/2}$	lower than sliding threshold at $N s_1$

- Relaxation becomes under-damped due to the appearance of a complex-bubble at the band floor.
- **Resistor network disorder** - Transition to complexity happens **before the percolation transition**.
- **Stochastic field disorder** - Transition to complexity happens **before the sliding transition**.
- Increasing further the affinity - **“complexity saturation”** is observed.